Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/667,456	TOISHI ET AL.
Examiner	Art Unit
Dr. Kelechi C. Egwim	1713

	0545	OUED			
	SEARCHED				
Class	Subclass	Date	Examiner		
526	242	1/18/200	KCE		
525	326.2	1/18/2005	KCE		
525	330.7	1/18/2005	KCE		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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(INCLUDING	SEARCH STRATEG	iY)
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BRS	1/18/200₫	KCE
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